

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

OptiMOS[™]

OptiMOS[™]5 Power-Transistor, 80 V IPP052N08N5

Data Sheet

Rev. 2.0 Final





IPP052N08N5

1 **Description**

Features

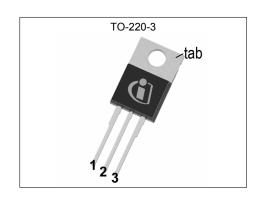
- Ideal for high frequency switching and sync. rec.
 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}

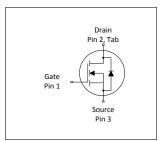
- N-channel, normal level

- 100% avalanche tested
 Pb-free plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target applications
 Halogen-free according to IEC61249-2-21



| Table 1 Rey Ferformance Farameters | | | | | | | |
|------------------------------------|-------|------|--|--|--|--|--|
| Parameter | Value | Unit | | | | | |
| V _{DS} | 80 | V | | | | | |
| R _{DS(on),max} | 5.2 | mΩ | | | | | |
| I _D | 80 | A | | | | | |
| Qoss | 51 | nC | | | | | |
| Q _G (0V10V) | 42 | nC | | | | | |











| Type / Ordering Code | Package | Marking | Related Links |
|----------------------|------------|----------|---------------|
| IPP052N08N5 | PG-TO220-3 | 052N08N5 | - |



IPP052N08N5

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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

| Davamatav | Cymphal | Val | | | | N | |
|--|-----------------------------------|------|----------------|----------|------|---|--|
| Parameter | Symbol | Min. | Min. Typ. Max. | | Unit | Note / Test Condition | |
| Continuous drain current | I _D | - | - | 80 78 | А | T _C =25 °C T _C =100 °C | |
| Pulsed drain current ¹⁾ | I _{D,pulse} | - | - | 320 | Α | <i>T</i> _C =25 °C | |
| Avalanche energy, single pulse ²⁾ | E AS | - | - | 84 | mJ | $I_{\rm D}$ =80 A, $R_{\rm GS}$ =25 Ω | |
| Gate source voltage | V _{GS} | -20 | - | 20 | V | - | |
| Power dissipation | P _{tot} | - | - | 125 | W | T _C =25 °C | |
| Operating and storage temperature | T _j , T _{stg} | -55 | - | 175 | °C | IEC climatic category; DIN IEC 68-1: 55/175/56 | |

Thermal characteristics 3

Table 3 **Thermal characteristics**

| Parameter | Symbol | Values | | | Unit | Note / Test Condition | |
|--|-------------------|--------|------|------|-------|-----------------------|--|
| raiailietei | Symbol | Min. | Тур. | Max. | Ullit | Note / Test Condition | |
| Thermal resistance, junction - case | R _{thJC} | - | 0.9 | 1.2 | K/W | - | |
| Thermal resistance, junction - ambient, minimal footprint | R_{thJA} | - | - | 62 | K/W | - | |
| Thermal resistance, junction - ambient, 6 cm ² cooling area ³⁾ | R _{thJA} | - | - | 40 | K/W | - | |
| Soldering temperature, wave and reflow soldering are allowed | T _{sold} | - | - | 260 | °C | reflow MSL1 | |

See figure 3 for more detailed information
 See figure 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.



Electrical characteristics

Table 4 **Static characteristics**

| Davamatav | Crossbad | | Values | | | Note / Test Condition | |
|----------------------------------|-----------------------|------|------------|------------|------|---|--|
| Parameter | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition | |
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | 80 | - | - | V | V _{GS} =0 V, I _D =1 mA | |
| Gate threshold voltage | V _{GS(th)} | 2.2 | 3.0 | 3.8 | V | $V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=66\ \mu{\rm A}$ | |
| Zero gate voltage drain current | I _{DSS} | - | 0.1 10 | 1 100 | μA | V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C | |
| Gate-source leakage current | I _{GSS} | - | 1 | 100 | nA | V _{GS} =20 V, V _{DS} =0 V | |
| Drain-source on-state resistance | R _{DS(on)} | - | 4.6 6.0 | 5.2 6.9 | mΩ | V _{GS} =10 V, I _D =80 A V _{GS} =6 V, I _D =40 A | |
| Gate resistance ¹⁾ | R _G | - | 1.1 | 1.7 | Ω | - | |
| Transconductance | g fs | 52 | 104 | - | S | $ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 80 \text{ A}$ | |

Dynamic characteristics¹⁾ Table 5

| Downwater | Cumbal | Values | | | I I mid | Note / Took Condition | |
|------------------------------|---------------------|--------|------|------|---------|--|--|
| Parameter | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition | |
| Input capacitance | Ciss | - | 2900 | 3770 | pF | V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz | |
| Output capacitance | Coss | - | 490 | 637 | pF | V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz | |
| Reverse transfer capacitance | Crss | - | 23 | 40 | pF | V _{GS} =0 V, V _{DS} =40 V, f=1 MHz | |
| Turn-on delay time | t _{d(on)} | - | 17 | - | ns | $V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =80 A, $R_{\rm G,ext}$ =1.6 Ω | |
| Rise time | t _r | - | 7 | - | ns | $V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =80 A, $R_{\rm G,ext}$ =1.6 Ω | |
| Turn-off delay time | t _{d(off)} | - | 27 | - | ns | $V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =80 A, $R_{\rm G,ext}$ =1.6 Ω | |
| Fall time | t _f | - | 7 | - | ns | $V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =80 A, $R_{\rm G,ext}$ =1.6 Ω | |

Gate charge characteristics²⁾ Table 6

| Davamatav | Sumb al | | Values | | | Note / Took Condition | |
|------------------------------------|----------------------|------|--------|------|------|--|--|
| Parameter | Symbol | Min. | Тур. | Max. | Unit | Note / Test Condition | |
| Gate to source charge | Q _{gs} | - | 15 | - | nC | $V_{\rm DD}$ =40 V, $I_{\rm D}$ =80 A, $V_{\rm GS}$ =0 to 10 V | |
| Gate to drain charge ¹⁾ | Q _{gd} | - | 9.4 | 14 | nC | $V_{\rm DD}$ =40 V, $I_{\rm D}$ =80 A, $V_{\rm GS}$ =0 to 10 V | |
| Switching charge | Q _{sw} | - | 16 | - | nC | $V_{\rm DD}$ =40 V, $I_{\rm D}$ =80 A, $V_{\rm GS}$ =0 to 10 V | |
| Gate charge total ¹⁾ | Qg | - | 42 | 53 | nC | $V_{\rm DD}$ =40 V, $I_{\rm D}$ =80 A, $V_{\rm GS}$ =0 to 10 V | |
| Gate plateau voltage | V _{plateau} | - | 5.2 | - | V | V_{DD} =40 V, I_{D} =80 A, V_{GS} =0 to 10 V | |
| Gate charge total, sync. FET | Q _{g(sync)} | - | 36 | - | nC | V _{DS} =0.1 V, V _{GS} =0 to 10 V | |
| Output charge ¹⁾ | Qoss | - | 51 | 68 | nC | V _{DD} =40 V, V _{GS} =0 V | |

 $^{^{\}rm 1)}$ Defined by design. Not subject to production test. $^{\rm 2)}$ See "Gate charge waveforms" for parameter definition



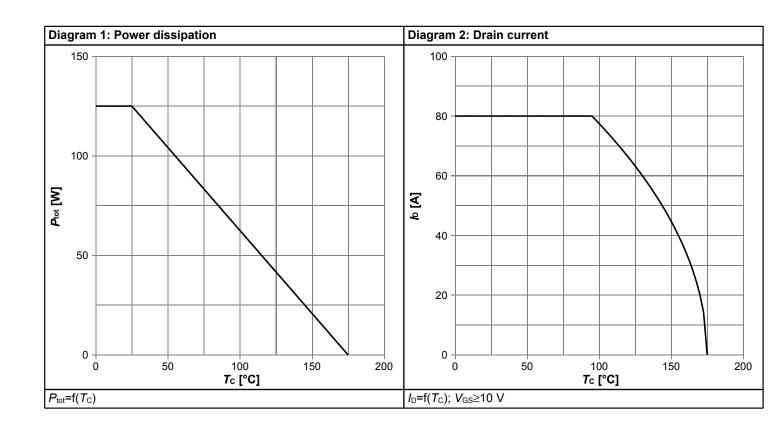
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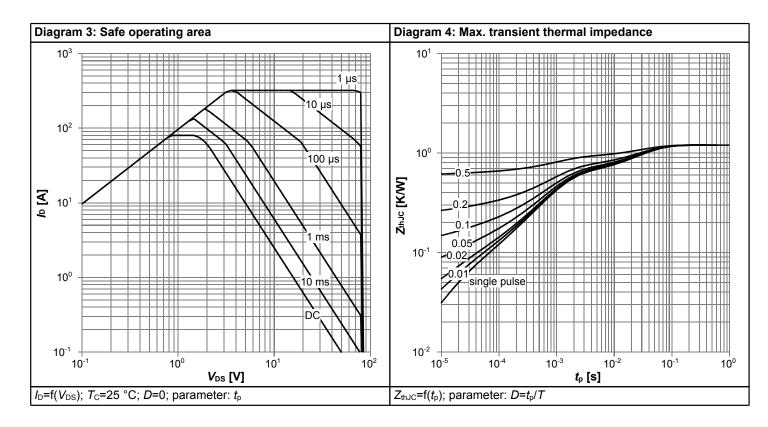
Table 7 Reverse diode

| Doromotor | Symbol | | Values | 5 | Unit | Note / Test Condition | |
|---------------------------------------|----------------------|------|--------|------|-----------------------|--|--|
| Parameter | Min. Typ. | Тур. | Max. | Unit | Note / Test Condition | | |
| Diode continous forward current | Is | - | - | 80 | Α | <i>T</i> _C =25 °C | |
| Diode pulse current | I _{S,pulse} | - | - | 320 | Α | T _C =25 °C | |
| Diode forward voltage | V _{SD} | - | 1.0 | 1.2 | V | V _{GS} =0 V, I _F =80 A, T _j =25 °C | |
| Reverse recovery time ¹⁾ | t _{rr} | - | 56 | 112 | ns | V _R =40 V, I _F =80A, di _F /d <i>t</i> =100 A/μs | |
| Reverse recovery charge ¹⁾ | Qrr | - | 92 | 184 | nC | V _R =40 V, I _F =80A, di _F /dt=100 A/μs | |

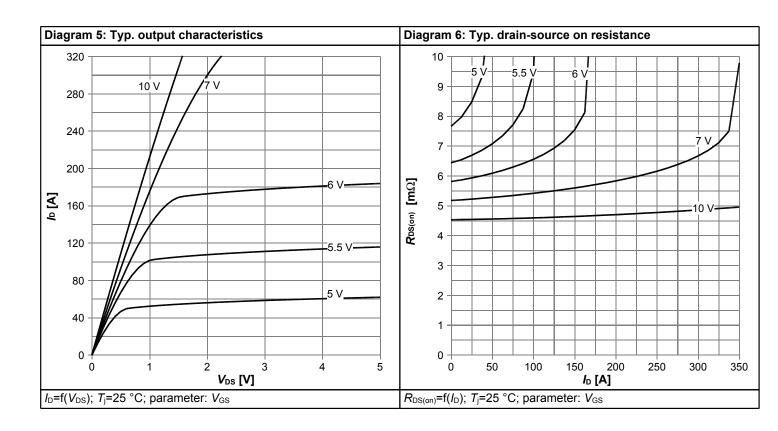


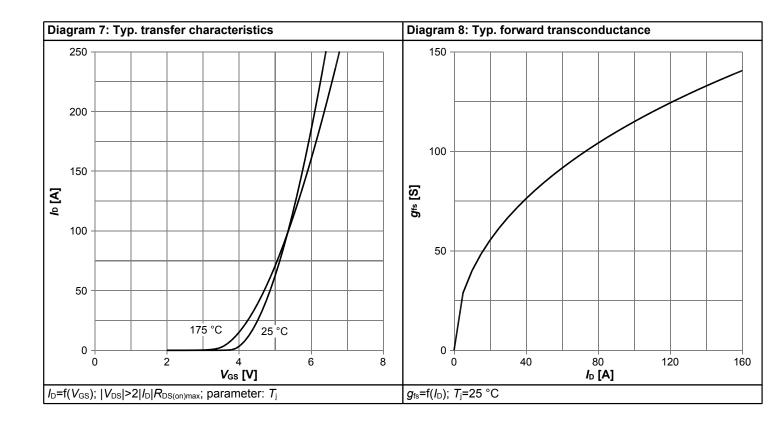
5 Electrical characteristics diagrams



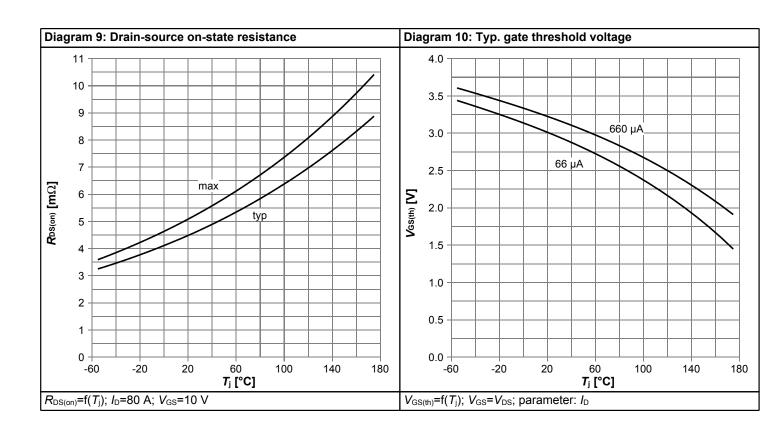


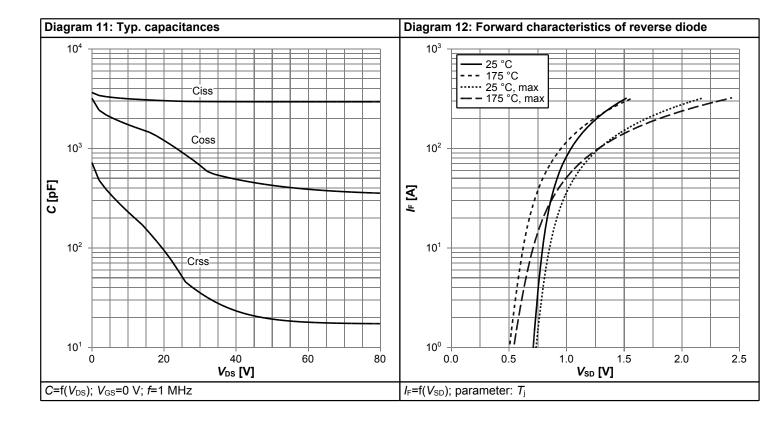




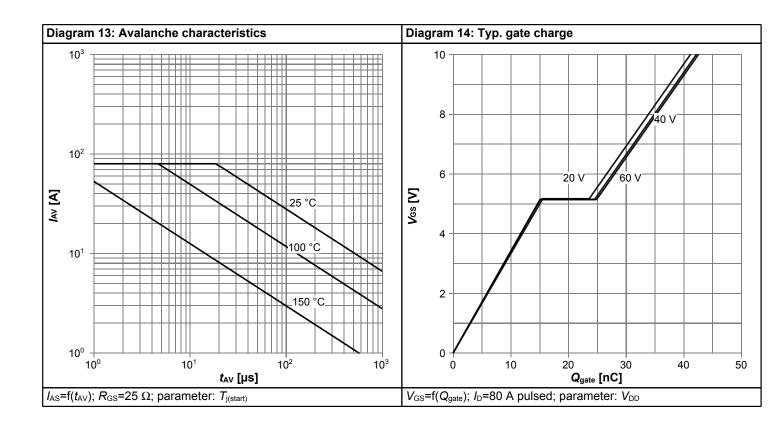


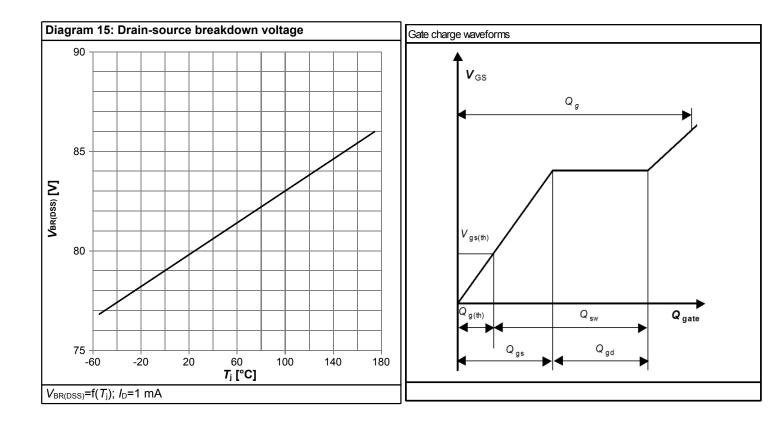






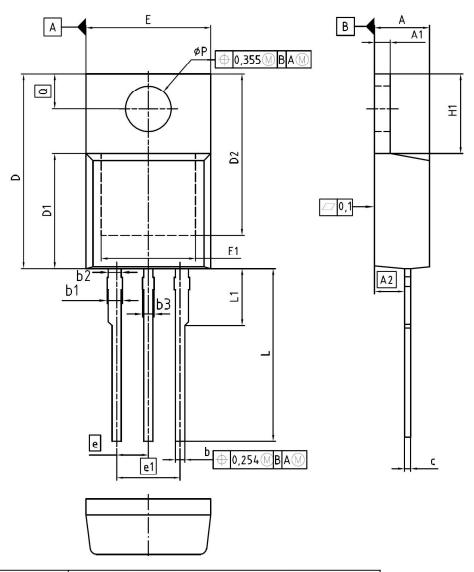








6 Package Outlines



| DIM | MILLIM | ETERS | INCHES | | | | |
|-----|--------|-------|--------|-------|--|--|--|
| DIM | MIN | MAX | MIN | MAX | | | |
| Α | 4.30 | 4.57 | 0.169 | 0.180 | | | |
| A1 | 1.17 | 1.40 | 0.046 | 0.055 | | | |
| A2 | 2.15 | 2.72 | 0.085 | 0.107 | | | |
| b | 0.65 | 0.86 | 0.026 | 0.034 | | | |
| b1 | 0.95 | 1.40 | 0.037 | 0.055 | | | |
| b2 | 0.95 | 1.15 | 0.037 | 0.045 | | | |
| b3 | 0.65 | 1.15 | 0.026 | 0.045 | | | |
| С | 0.33 | 0.60 | 0.013 | 0.024 | | | |
| D | 14.81 | 15.95 | 0.583 | 0.628 | | | |
| D1 | 8.51 | 9.45 | 0.335 | 0.372 | | | |
| D2 | 12.19 | 13.10 | 0.480 | 0.516 | | | |
| Ε | 9.70 | 10.36 | 0.382 | 0.408 | | | |
| E1 | 6.50 | 8.60 | 0.256 | 0.339 | | | |
| е | 2. | 54 | 0.100 | | | | |
| e1 | 5. | 08 | 0.2 | :00 | | | |
| N | | 3 | 3 | 3 | | | |
| H1 | 5.90 | 6.90 | 0.232 | 0.272 | | | |
| L | 13.00 | 14.00 | 0.512 | 0.551 | | | |
| L1 | - | 4.80 | - | 0.189 | | | |
| øΡ | 3.60 | 3.89 | 0.142 | 0.153 | | | |
| 0 | 2.60 | 3.00 | 0.102 | 0.118 | | | |

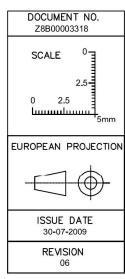


Figure 1 Outline PG-TO220-3, dimensions in mm/inches



IPP052N08N5

Revision History

IPP052N08N5

Revision: 2014-12-17, Rev. 2.0

Revision. 2014-12-17, Rev. 2

| Previous Revision | | | | | | |
|-------------------|------------|--|--|--|--|--|
| Revision | Date | Subjects (major changes since last revision) | | | | |
| 2.0 | 2014-12-17 | Release of final version | | | | |

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